

CE Test Report

Product Name: SY210NT CONTROLLER SERIES Model No.: SY210NT2-TSN, SY210NT4-SSN, SY210NT2-OSN, SY210NT4-FSN, MDDIDO-16, MDDIDO-1S, MDWIE-1S, SYLINK-F, MDNET-1, MDNET-95A

Applicant : SYRIS TECHNOLOGY CORP.

Address : 21F-2,NO.12, Sec.1, Taijunggang Rd., Taichung, Taiwan, R.O.C.

Date of Receip	t :	Jun. 30, 2003
Date of Test	:	Jul. 16, 2003
Report No.	:	037H015E

The Test Results relate only to the samples tested.

The test report shall not be reproduced except in full without the written approval of QuieTek Corporation.



The following products is herewith confirmed to comply with the requirements set out in the Council Directive on the Approximation of the laws of the Member States relating to Electromagnetic Compatibility Directive (89/336/EEC). The listed standard as below were applied:

The following Equipment:

Product	:	SY210NT CONTROLLER SERIES
Trade Name	:	SYRIS
Model Number	:	SY210NT2-TSN, SY210NT4-SSN, SY210NT2-OSN,
		SY210NT4-FSN, MDDIDO-16, MDDIDO-1S, MDWIE-1S,
		SYLINK-F, MDNET-1, MDNET-95A

This product is herewith confirmed to comply with the requirements set out in the Council Directive on the Approximation of the laws of the Member States relating to Electromagnetic Compatibility Directive (89/336/EEC).For the evaluation regarding EMC, the following standards were applied:

RFI Emission:

EN 50081-1:1992 Class B	: Emission standard
EN 61000-3-2:1995 Class A Amendment 1:1998 Amendment 2:1998	: Limits for harmonic current emission
EN 61000-3-3:1995	: Limitation of voltage fluctuation and flicker in low-voltage supply system

Immunity :

EN 50130-4:1995+A1: 1998 : Immunity standard

:

The following importer/manufacturer is responsible for this declaration:

Company Name

Company Address	:	
Telephone	:	Facsimile :

Person is responsible for marking this declaration:

Name (Full Name)

Position/ Title

Date

Legal Signature



EMC/Safety Test Laboratory Accredited by DNV, TUV, Nemko and NVLAP

Date: Jul. 16, 2003 QTK No.: 037H015E

CE Statement of Conformity

The certifies that the following designated product

Product	:	SY210NT CONTROLLER SERIES
Trade name	:	SYRIS
Model Number	:	SY210NT2-TSN, SY210NT4-SSN, SY210NT2-OSN, SY210NT4-FSN, MDDIDO-16, MDDIDO-1S, MDWIE-1S , SYLINK-F, MDNET-1, MDNET-95A
Company Name	:	SYRIS TECHNOLOGY CORP.

This product is herewith confirmed to comply with the requirements set out in the Council Directive on the Approximation of the laws of the Member States relating to Electromagnetic Compatibility Directive (89/336/EEC). For the evaluation regarding EMC, the following standards were applied:

RFI Emission:

Immunity .	
EN 61000-3-3:1995	: Limitation of voltage fluctuation and flicker in low-voltage supply system
Amendment 2:1998	
Amendment 1:1998	
EN 61000-3-2:1995 Class A	: Limits for harmonic current emission
EN 50081-1:1992 Class B	: Emission standard

Immunity :

EN 50130-4:1995+A1: 1998 : Immunity standard



TEST LABORATORY

Kevin Wang/ Manager

The verification is based on a single evaluation of one sample of above-mentioned products. It does not imply an assessment of the whole production and does not permit the use of the test lab. Logo.

Test Report Certification Test Date : Jul. 16, 2003 Report No. : 037H015E Corporation Quie ек Accredited by TUV, DNV, Nemko and NIST (NVLAP) Product Name : SY210NT CONTROLLER SERIES : SYRIS TECHNOLOGY CORP. Applicant Address : 21F-2,NO.12, Sec.1, Taijunggang Rd., Taichung, Taiwan, R.O.C. Manufacturer : SYRIS TECHNOLOGY CORP. Model No. : SY210NT2-TSN, SY210NT4-SSN, SY210NT2-OSN, SY210NT4-FSN, MDDIDO-16, MDDIDO-1S, MDWIE-1S, SYLINK-F, MDNET-1, MDNET-95A Rated Voltage : DC 12V(Power by Battery) Trade Name : SYRIS Measurement Standard : EN 50081-1:1992 Class B EN 61000-3-2:1995, Amendment 1:1998, Amendment 2:1998 EN 61000-3-3:1995 EN 50130-4:1995+A1: 1998 Measurement Procedure : EN 50081-1:1992, EN 61000-3-2:1995, EN 61000-3-3:1995, IEC 1000-4-2:1995, IEC 1000-4-3:1995, IEC 1000-4-4:1995, IEC 1000-4-5:1995, ENV 50141:1993, IEC 1000-4-11:1994 Test Result : Complied

The Test Results relate only to the samples tested.

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Documented By	:	Carol Tsai	<u> </u>
T . 15		(Carol Tsai)	
Tested By	:	(Carter Hsu)	<u>alvn</u>
Approved By	:		NVLAP Lab Code : 200347-0
		(Kevin Wang)	(N) NEMKO